

Description

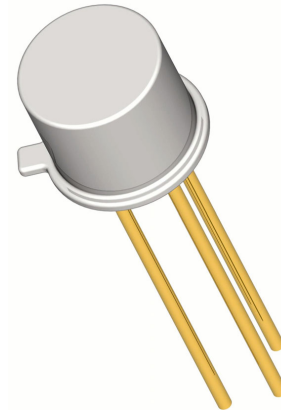
SEMICOA Corporation offers:

- Screening and processing per MIL-PRF-19500
- JAN level (2N3700J)
- JANTX level (2N3700JX)
- JANTXV level (2N3700JV)
- JANS level (2N3700JS)
- JANSR level (2N3700JSR)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV and JANS
- Radiation testing (total dose) upon request

Please contact SEMICOA for special configurations
www.SEMICOA.com or (714) 979-1900

Applications

- General purpose
- Low power
- NPN silicon transistor



Features

- Hermetically sealed TO-18 metal can
- Also available in chip configuration
- Chip geometry 4500
- Reference document: MIL-PRF-19500/391

Benefits

- Qualification Levels: JAN, JANTX, JANTXV, JANS and JANSR
- Radiation testing available

Absolute Maximum Ratings		T _c = 25°C unless otherwise specified	
Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V _{CEO}	80	Volts
Collector-Base Voltage	V _{CBO}	140	Volts
Emitter-Base Voltage	V _{EBO}	7	Volts
Collector Current, Continuous	I _C	1	A
Power Dissipation, T _A = 25°C Derate linearly above 37.5°C	P _T	0.5 3.08	W mW/°C
Power Dissipation, T _C = 25°C Derate linearly above 25°C	P _T	1.8 10.3	W mW/°C
Thermal Resistance	R _{θJA}	325	°C/W
Operating Junction Temperature	T _J	-65 to +200	°C
Storage Temperature	T _{STG}		

ELECTRICAL CHARACTERISTICS

characteristics specified at $T_A = 25^\circ\text{C}$

Off Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = 30 \text{ mA}$	80			Volts
Collector-Base Cutoff Current	I_{CBO1}	$V_{CB} = 140 \text{ Volts}$			10	μA
Collector-Emitter Cutoff Current	I_{CES1}	$V_{CE} = 90 \text{ Volts}$			10	nA
Collector-Emitter Cutoff Current	I_{CES2}	$V_{CE} = 90 \text{ Volts}, T_A = 150^\circ\text{C}$			10	μA
Emitter-Base Cutoff Current	I_{EBO1}	$V_{EB} = 7 \text{ Volts}$			10	μA
Emitter-Base Cutoff Current	I_{EBO2}	$V_{EB} = 5 \text{ Volts}$			10	nA

On Characteristics			Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$			
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	h_{FE1}	$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ Volts}$	100		300	
	h_{FE2}	$I_C = 0.1 \text{ mA}, V_{CE} = 10 \text{ Volts}$	50		200	
	h_{FE3}	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ Volts}$	90			
	h_{FE4}	$I_C = 500 \text{ mA}, V_{CE} = 10 \text{ Volts}$	50		200	
	h_{FE5}	$I_C = 1 \text{ A}, V_{CE} = 10 \text{ Volts}$	15			
	h_{FE6}	$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ Volts}$ $T_A = -55^\circ\text{C}$	40			
Base-Emitter Saturation Voltage	V_{BEsat}	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$			1.1	Volts
Collector-Emitter Saturation Voltage	V_{CEsat1}	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$			0.2	Volts
	V_{CEsat2}	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			0.5	Volts

Dynamic Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{FE} $	$V_{CE} = 10 \text{ Volts}, I_C = 50 \text{ mA}, f = 20 \text{ MHz}$	5		20	
Small Signal Short Circuit Forward Current Transfer Ratio	h_{FE}	$V_{CE} = 5 \text{ Volts}, I_C = 1 \text{ mA}, f = 1 \text{ kHz}$	80		400	
Open Circuit Output Capacitance	C_{OBO}	$V_{CB} = 10 \text{ Volts}, I_E = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			12	pF
Open Circuit Input Capacitance	C_{IBO}	$V_{EB} = 0.5 \text{ Volts}, I_C = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			60	pF
Collector Base time constant	$\tau_b \cdot C_C$	$V_{CB} = 10 \text{ Volts}, I_E = 10 \text{ mA}, f = 79.8 \text{ MHz}$			400	ps
Noise Figure	NF	$V_{CE} = 10 \text{ Volts}, I_C = 100 \mu\text{A}, f = 200 \text{ Hz}, R_g = 1 \text{ k}\Omega$			4	dB

Switching Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Saturated Turn-On Time	$t_{ON} + t_{OFF}$				30	ns